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ZXMHC3F381N8

30V SO8 Complementary enhancement mode MOSFET H-Bridge

Summary

Device	$V_{(BR)DSS}$	\mathbf{Q}_{G}	R _{DS(on)}	I _D T _A = 25°C
N CU	201/	0.050	33mΩ @ V _{GS} = 10V	5.0A
N-CH	30V	9.0nC	60mΩ @ V _{GS} = 4.5V	3.9A
D OIL	201/	10.750	55mΩ @ V _{GS} = -10V	-4.1A
P-CH	-30V	12.7nC	80mΩ @ V _{GS} = -4.5V	-3.3A



Description

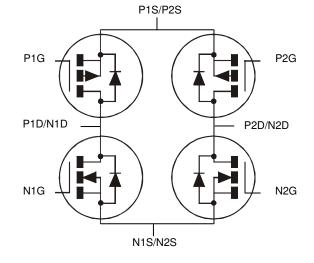
This new generation complementary MOSFET H-Bridge features low on-resistance achievable with low gate drive.

Features

- 2 x N + 2 x P channels in a SOIC package
- Low voltage (V_{GS} = 4.5 V) gate drive

Applications

- · DC Motor control
- DC-AC Inverters

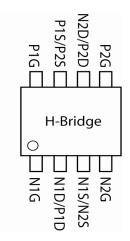


Ordering information

Device	Reel size (inches)	Tape width (mm)	Quantity per reel	
ZXMHC3F381N8TC	13	12	2,500	

Device marking

ZXMHC 3F381



Absolute maximum ratings

Parameter	Symbol	N- channel	P- channel	Unit
Drain-Source voltage	V_{DSS}	30	-30	٧
Gate-Source voltage	V _{GS}	±20	±20	V
Continuous Drain current @ V _{GS} = 10V; T _A =25°C (b)	I _D	4.98	-4.13	Α
@ $V_{GS} = 10V; T_A = 70^{\circ}C^{(b)}$		3.98	-3.31	
@ $V_{GS} = 10V; T_A = 25^{\circ}C^{(a)}$		3.98	-3.36	
@ V_{GS} = 10V; T_L =25°C ^(f)		4.17	-3.51	
Pulsed Drain current @ V _{GS} = 10V; T _A =25°C (C)	I _{DM}	22.9	-19.6	Α
Continuous Source current (Body diode) at T _A =25°C (b)	I _S	2.0	-2.0	Α
Pulsed Source current (Body diode) at T _A =25°C (c)	I _{SM}	22.9	-19.6	Α
Power dissipation at T _A =25°C ^(a)	P _D	P _D 0.87		W
Linear derating factor		6.	94	mW/°C
Power dissipation at T _A =25°C (b)	PD	1.3	W	
Linear derating factor	_	10).9	mW/°C
Power dissipation at T _L =25°C (f)	PD	0.95	0.98	W
Linear derating factor	_	7.63	7.81	mW/°C
Operating and storage temperature range	T _j , T _{stg}	-55 to	150	°C

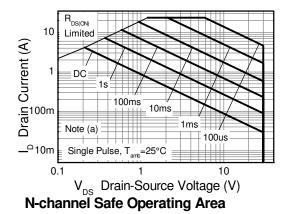
Thermal resistance

Parameter	Symbol	Value		Unit	
Junction to ambient ^(a)	$R_{\theta JA}$	14	144		
unction to ambient ^(b) R _{θJA} 92		2	°C/W		
Junction to ambient (d)	$R_{\theta JA}$	106		°C/W	
ction to ambient ^(e) R _{θJA} 254		54	°C/W		
Junction to lead ^(f)	$R_{ heta JL}$	131	128	°C/W	

NOTES:

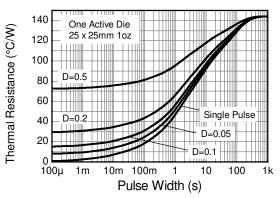
- (a) For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions with the heat-sink split into two equal areas (one for each drain connection); the device is measured when operating in a steady-state condition with one active die.
- (b) Same as note (a), except the device is measured at $t \le 10$ sec.
- (c) Same as note (a), except the device is pulsed with D= 0.02 and pulse width 300 μs. The pulse current is limited by the maximum junction temperature.
- (d) For a device surface mounted on 50mm x 50mm x 1.6mm FR4 PCB with high coverage of single sided 2oz copper, in still air conditions with the heat-sink split into two equal areas (one for each drain connection); the device is measured when operating in a steady-state condition with one active die.
- (e) For a device surface mounted on minimum copper 1.6mm FR4 PCB, in still air conditions; the device is measured when operating in a steady-state condition with one active die.
- (f) Thermal resistance from junction to solder-point (at the end of the drain lead); the device is operating in a steady-state condition with one active die.

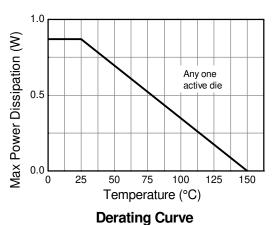
Thermal characteristics



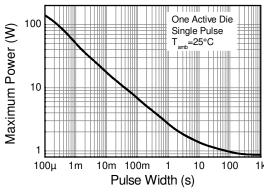
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 ${}^{-}V_{\scriptscriptstyle DS}$ Drain-Source Voltage (V) **P-channel Safe Operating Area**





Transient Thermal Impedance



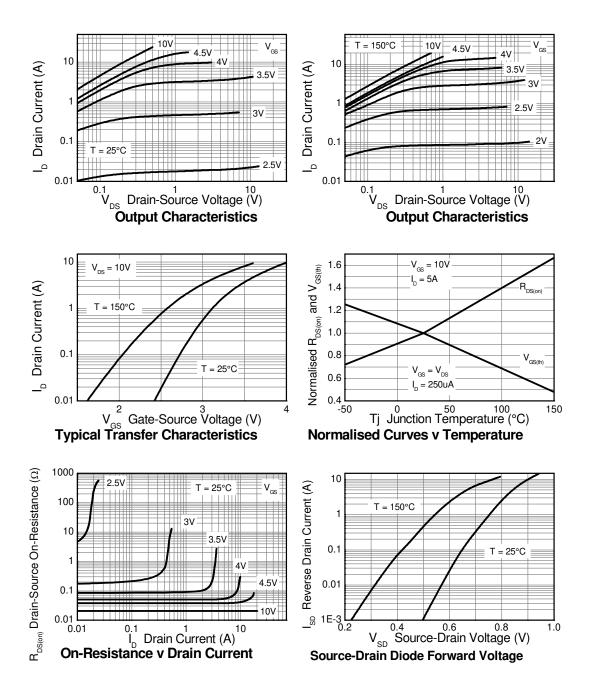
Pulse Power Dissipation

N-channel electrical characteristics (at T_{amb} = 25°C unless otherwise stated)

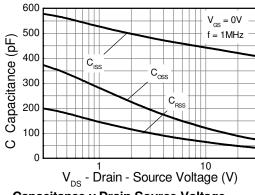
Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Static						
Drain-Source breakdown voltage	V _{(BR)DSS}	30			V	$I_D = 250 \mu A, V_{GS} = 0 V$
Zero Gate voltage Drain current	I _{DSS}			0.5	μΑ	V _{DS} = 30V, V _{GS} = 0V
Gate-Body leakage	I _{GSS}			±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
Gate-Source threshold voltage	V _{GS(th)}	1.0		3.0	V	$I_{D}\text{= }250\mu\text{A},V_{DS}\text{= }V_{GS}$
Static Drain-Source on-state resistance (a)	R _{DS(on)}			0.033 0.060	Ω	V _{GS} = 10V, I _D = 5A V _{GS} = 4.5V, I _D = 4A
Forward Transconductance (a) (c)	g _{fs}		11.8		S	V _{DS} = 15V, I _D = 5A
Dynamic						
Capacitance (c)			_		_	
Input capacitance	C _{iss}		430		pF	
Output capacitance	Coss		101		pF	V _{DS} = 15V, V _{GS} = 0V
Reverse transfer capacitance	C _{rss}		56		pF	f= 1MHz
Switching (b) (c)						
Turn-on-delay time	t _{d(on)}		2.5		ns	
Rise time	t _r		3.3		ns	$V_{DD} = 15V, V_{GS} = 10V$
Turn-off delay time	t _{d(off)}		11.5		ns	$I_{D}=1A$ $R_{G}\cong 6\Omega$,
Fall time	t _f		6.3		ns	11G = 052,
Gate charge ^(c)						
Total Gate charge	Qg		9.0		nC	
Gate-Source charge	Q _{gs}		1.7		nC	V_{DS} =15V, V_{GS} = 10V I_{D} = 5A
Gate-Drain charge	Q_{gd}		2.0		nC	
Source-Drain diode						
Diode forward voltage (a)	V_{SD}		0.82	1.2	V	I _S = 1.7A, V _{GS} = 0V
Reverse recovery time (c)	t _{rr}		12		ns	I _S = 2.1A, di/dt= 100A/μs
Reverse recovery charge ^(c)	Q _{rr}		4.9		nC	15- 2.17, αναι- 1007/μ5

⁽a) Measured under pulsed conditions. Pulse width $\leq 300 \mu s$; duty cycle $\leq 2\%$. (b) Switching characteristics are independent of operating junction temperature. (c) For design aid only, not subject to production testing

N-channel typical characteristics



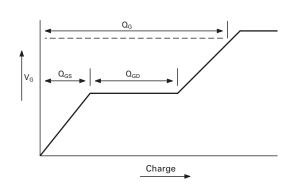
N-channel typical characteristics -continued



Capacitance v Drain-Source Voltage

Gate-Source Voltage v Gate Charge

Test circuits

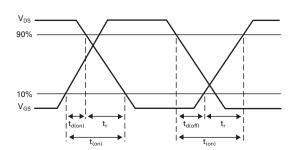


Current regulator

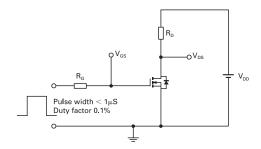
12V 0.2μF 50k Same as D.U.T

V_{DS}

Basic gate charge waveform



Gate charge test circuit



Switching time waveforms

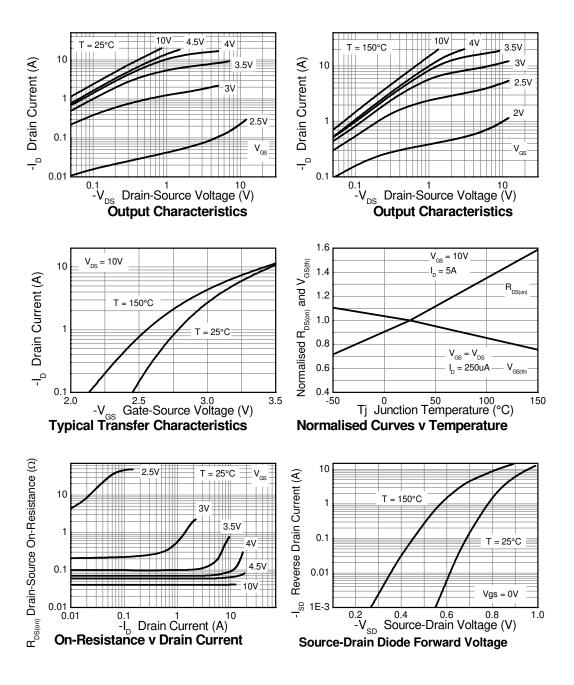
Switching time test circuit

P-channel electrical characteristics (at T_{amb} = 25°C unless otherwise stated)

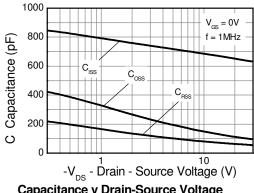
Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Static						
Drain-Source breakdown voltage	V _{(BR)DSS}	-30			V	$I_D = -250 \mu A, V_{GS} = 0 V$
Zero Gate voltage Drain current	I _{DSS}			-0.5	μΑ	V _{DS} = -30V, V _{GS} = 0V
Gate-Body leakage	I _{GSS}			±100	nA	V_{GS} = ±20V, V_{DS} = 0V
Gate-Source threshold voltage	V _{GS(th)}	-1.0		-3.0	V	I_{D} = -250 μ A, V_{DS} = V_{GS}
Static Drain-Source on-state resistance (a)	R _{DS(on)}			0.055 0.080	Ω	V _{GS} = -10V, I _D = -5A V _{GS} = -4.5V, I _D = -4A
Forward Transconductance (a) (c)	9fs		14		S	V _{DS} = -15V, I _D = -5A
Dynamic						
Capacitance (c)			_		_	
Input capacitance	C _{iss}		670		рF	
Output capacitance	Coss		126		pF	V _{DS} = -15V, V _{GS} = 0V
Reverse transfer capacitance	C _{rss}		70		pF	f= 1MHz
Switching (b) (c)						
Turn-on-delay time	t _{d(on)}		1.9		ns	
Rise time	t _r		3.0		ns	V _{DD} = -15V, V _{GS} = -10V
Turn-off delay time	t _{d(off)}		30		ns	T _D = -1A - R _G ≅ 6Ω
Fall time	t _f		21		ns	1 1G = 022
Gate charge ^(c)						
Total Gate charge	Qg		12.7		nC	
Gate-Source charge	Q _{gs}		2.0		nC	V_{DS} = -15V, V_{GS} = -10V I_{D} = -5A
Gate-Drain charge	Q _{gd}		2.4		nC	1 _D = 3/1
Source-Drain diode						
Diode forward voltage (a)	V _{SD}		-0.82	-1.2	٧	I _S = -1.7A, V _{GS} = 0V
Reverse recovery time (c)	t _{rr}		16.5		ns	-I _S = -2.1A, di/dt= 100A/μs
Reverse recovery charge ^(c)	Q _{rr}		11.5		nC	, 1131 1331 1

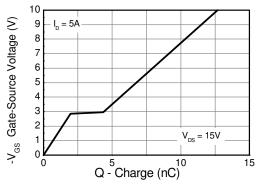
⁽a) Measured under pulsed conditions. Pulse width $\leq 300 \mu s$; duty cycle $\leq 2\%$. (b) Switching characteristics are independent of operating junction temperature. (c) For design aid only, not subject to production testing

P-channel typical characteristics



P-channel typical characteristics -continued

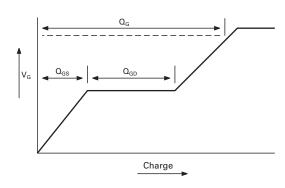




Capacitance v Drain-Source Voltage

Gate-Source Voltage v Gate Charge

Test circuits

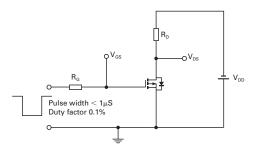


Current regulator J**⊑** ₽.U.T

Basic gate charge waveform

 V_{DS} 90%

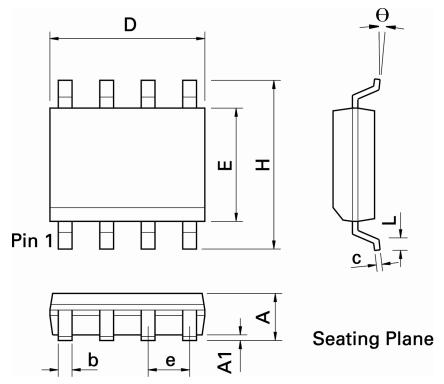
Gate charge test circuit



Switching time waveforms

Switching time test circuit

Packaging details - SO8



DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
Α	0.053	0.069	1.35	1.75	е	0.050 BSC		1.27 BSC	
A1	0.004	0.010	0.10	0.25	b	0.013	0.020	0.33	0.51
D	0.189	0.197	4.80	5.00	С	0.008	0.010	0.19	0.25
Н	0.228	0.244	5.80	6.20	θ	0°	8°	0°	8°
Е	0.150	0.157	3.80	4.00	-	-	-	-	-
L	0.016	0.050	0.40	1.27	-	-	-	-	-

Note: Controlling dimensions are in inches. Approximate dimensions are provided in millimeters

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